

SPECIFICATION

HIGH-FREQUENCY OSCILLATION CIRCUIT

5 FIELD OF THE INVENTION

10 The present invention relates to a high-frequency oscillation circuit, and more particularly, to a high-frequency oscillation circuit useful for enhancing sensitivity of various measuring instruments used as weight sensor, chemical sensor, biosensor, viscosity sensor, film thickness meter, gas sensor, floating dust sensor, immunity sensor or the like.

BACKGROUND OF THE INVENTION

15 While recently various measuring instruments using crystal as weight sensor, chemical sensor, biosensor, viscosity sensor, film thickness meter or the like have been numerously developed, it has been needed urgently to develop a high precision and highly sensitive measuring
20 instruments to cope with such a demand for diversity of materials to be detected and precise quantitative determination of materials to be detected.

As is generally known, however, a wafer used for a crystal oscillator has such a nature as to cause
25 distortion (piezo-electric effect) when a voltage is

applied to thin film electrodes attached to both side
faces thereof and return to its initial state when
the voltage is removed. Because of this nature, a crystal
oscillator oscillates at a natural frequency determined by
5 its thickness. Thereby, in a crystal wafer, when its
thickness varies by adsorbing a substance, a basic
frequency (i.e., the natural oscillation frequency or
basic oscillation frequency) of the crystal oscillator is
varied.

10 The change Δf of this natural oscillation frequency is
proportionate to a change in thickness. If the change in
thickness dimension is replaced by a change Δm in mass,
the following equation called Sauerbrey's equation can be
introduced.

15
$$\Delta f = - \{ 2f_0^2 / (\rho q \times \mu q)^{1/2} \} \times (\Delta m / A)$$

wherein f_0 is a basic oscillation frequency, ρq and μq
are density and elastic modulus of the crystal,
respectively, and A is the area of a portion performing
piezo-electric response.

20 From this equation, it is understood that, since the
sensitivity Δf is proportionate to the square of the basic
oscillation frequency f_0 , it is desirable to use a crystal
oscillator whose f_0 is great. However, if f_0 becomes too
great, the thickness is reduced, and the oscillator tends
25 to be easily broken. Therefore, it is general to use a

crystal oscillator whose f_0 is between 5 and 10 MHz under the normal atmosphere, and even in a solution, merely a crystal oscillator whose greatest oscillation frequency f_0 is 30 MHz is used, and a measurement exceeding the maximum
5 detection limit of a general-purpose crystal oscillator has not yet been attained.

While there is also an example of measurement using the seventh order overtone mode (63 MHz) of a crystal oscillator whose f_0 is 9MHz, its detection limit is
10 reported as 0.1 ng, which showed no remarkable improvement in sensitivity, compared with the conventional method of 1 ng ("The Latest Method of Separation, Purification and Detection", p. 441, by NTS Publishing Co., issued May 26, 1997).

15 On the other hand, in contrast with such a situation as above, there is also proposed a high-frequency oscillation circuit using a crystal oscillator not as a weight sensor but for controlling the frequency of an oscillation circuit.

20 However, in many cases these circuits were analog circuits which are complicated and hard-to-adjust as numerous parts such as transistor, coupling transformer, inductance, etc., are used, and were expensive and not suitable to be used as a measuring instrument for various
25 sensors.

A low-frequency oscillation circuit~~s~~ using a logic element in part is known (JP-A-3-165236 ("JP-A" means unexamined published Japanese patent application), "The Electronic Circuit Parts Utilization Handbook", p.67, by CQ Publishing Co., issued on November 1, 1985). This oscillation circuit~~s~~, however, use~~s~~ only an oscillator having a natural frequency in a low-frequency area, so that it cannot cope with a demand for higher sensitivity, making it hard to realize a high-frequency oscillation circuit showing high-frequency stability. Furthermore, there was a need to design and constitute an oscillation circuit to suit a crystal oscillator to be oscillated and its frequency (Japanese patent application No. 2000-31513).

SUMMARY OF THE INVENTION

The present invention overturns common knowledge of a conventional oscillation circuit.

The present invention aims to provide a high-frequency oscillation circuit which can keep a stable high-frequency oscillation to easily cope with the natural oscillation frequency of a crystal oscillator as a sensor even if it becomes high, and yet which can be easily manufactured at a low cost.

Other and further objects, features, and advantages of the invention will appear more fully from the following description, take in connection with the accompanying

drawings.

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BRIEF DESCRIPTION OF THE DRAWINGS

Fig. 1(a) is a diagram showing an embodiment of a
5 high-frequency oscillation circuit using a logic element
"NAND" and a crystal oscillator having a basic oscillation
frequency of 50 MHz.

Fig. 1(b) is a graph showing an oscillation waveform
of the circuit in Fig. 1(a).

10 Fig. 2(a) is a diagram showing an embodiment of a
high-frequency oscillation circuit using a logic element
"NAND" and a crystal oscillator having a basic oscillation
frequency of 100 MHz.

Fig. 2(b) is a graph showing an oscillation waveform
15 of the circuit in Fig. 2(a).

Fig. 3(a) is a diagram showing an embodiment of a
high-frequency oscillation circuit using a logic element
"inverter" and a crystal oscillator having a basic
oscillation frequency of 155 MHz.

20 Fig. 3(b) is a graph showing an oscillation waveform
of the circuit in Fig. 3(a).

Fig. 4(a) is a diagram showing an embodiment of a
high-frequency oscillation circuit using a logic element
"inverter" and an overtone crystal oscillator of 100 MHz.

25 Fig. 4(b) is a graph showing an oscillation waveform

of the circuit in Fig. 4(a).

Fig. 5 is a graph showing the stability of an oscillation frequency per hour of the circuit shown in Fig. 2(a) in case of using a normal crystal oscillator.

5 Fig. 6 is a graph showing the stability of an oscillation frequency per hour of the circuit shown in Fig. 2(a) in case of using a crystal oscillator on which a styrene film was deposited for one minute by the plasma polymerization method.

10 Fig. 7 is a diagram showing another embodiment of the high-frequency oscillation circuit of the present invention.

Fig. 8(a) is a graph showing an oscillation waveform measured by oscilloscope in case a crystal oscillator
15 having a basic oscillation frequency of 20 MHz is used in the circuit shown in Fig. 7.

Fig. 8(b) is a graph showing an oscillation waveform measured by oscilloscope in case a crystal oscillator having a basic oscillation frequency of 33 MHz is used in
20 the circuit shown in Fig. 7.

Fig. 8(c) is a graph showing an oscillation waveform measured by oscilloscope in case a crystal oscillator with a basic oscillation frequency of 50 MHz is used in the circuit shown in Fig. 7.

25 Fig. 8(d) is a graph showing an oscillation waveform

measured by oscilloscope in case a crystal oscillator having a basic oscillation frequency of 155 MHz is used in the circuit shown in Fig. 7.

Fig. 9(a) is a graph showing changes in the oscillation frequency with the lapse of time when one of the oscillation circuits of Fig. 7 is used and saturated acetone steam of the same concentration is adsorbed on crystal oscillators coated with a plasma polymerized styrene film of the same weight .

Fig. 9(b) is an enlarged graph of the measurement result by using the crystal oscillator having the basic oscillation frequency of 9 MHz in Fig. 9(a).

DETAILED DESCRIPTION OF THE INVENTION

Studying hard to solve the foregoing problems, the inventor used a readily available logic element, made a closed circuit by connecting its input and output with a capacitor, a resistor and a crystal oscillator having a natural oscillation frequency in a high-frequency area, and discovered that an oscillation circuit capable of keeping a more stable high-frequency oscillation can be unexpectedly obtained by the operation time or response speed of the logic element, the time constant of the capacitor and the resistor or the like, resulting in completion of the present invention.

The present invention provides a high-frequency oscillation circuit characterized by incorporating a crystal oscillator having a natural oscillation frequency (i.e., basic oscillation frequency) in a high-frequency
5 area into a closed circuit including a logic element.

In the present invention, a closed circuit is formed by using a logic element. It is possible to use a readily available logic element such as NAND circuit, NOR circuit, inverter or the like which is heretofore publicly known,
10 but it is preferable to use a high-speed TTL (Transistor-Transistor Logic) element or CMOS (Complementary Metal Oxide Semiconductor) element so as to cope with a high-frequency oscillation. Also, in a high-frequency oscillation circuit into which a crystal oscillator having
15 a basic oscillation frequency in a high-frequency area is incorporated, it is possible to use a logic element CMOS, which is fast in the response speed, so as to cope with the high frequency.

As a crystal oscillator having a natural oscillation
20 frequency in a high-frequency area, a crystal oscillator having a natural oscillation frequency corresponding to the oscillation frequency of the circuit generally between 30 and 1800 MHz, preferably between 50 and 1800 MHz, more preferably between 100 and 1800 MHz, and the most
25 preferably between 150 and 1800 MHz can be given. As

another crystal oscillator for high frequency, a crystal oscillator having a basic oscillation frequency corresponding to an oscillation frequency generally between 1 MHz and 2GHz, preferably of 150 MHz or more can
5 be given as an example.

In the high-frequency oscillation circuit relative to the present invention, it is possible to incorporate a crystal oscillator having a basic oscillation frequency in a high-frequency area into a closed circuit including a
10 high-frequency CMOS as a logic element. This oscillation circuit has quite a novel circuit content and circuit constitution of a type that could not be anticipated or expected by the conventional electronic circuit. Such a high-frequency oscillation circuit as this is suited for
15 oscillation of an oscillator, particularly a crystal oscillator for chemical measurement.

The closed circuit in the present invention can be formed by connecting a capacitor, a resistor and a crystal oscillator having a natural oscillation frequency in a
20 high-frequency area to the input and output of such a logic element, and properly adjusting an operation time or response speed of the logic element, the natural oscillation frequency of the crystal oscillator, and the time constant or the like of the capacitor and resistor.

25 As a concrete circuit constitution of the closed

circuit, such an embodiment as one using, for example, two
NANDs or one inverter can be given. However, in view of a
sustained oscillation property of a stable high
oscillation frequency, an embodiment to select a high-
5 speed TTL or CMOS to suit the natural oscillation
frequency in a high-frequency area of the crystal
oscillator incorporated into the closed circuit, or an
embodiment to select a logic element CMOS having a
response speed capable of coping with the basic
10 oscillation frequency in the high-frequency area is
preferable.

As another preferable embodiment of the present
invention, the following embodiments can be mentioned.

- (1) A high-frequency oscillation circuit having high-
15 frequency stability, which comprises a crystal oscillator
for high frequency disposed within a closed circuit that
is formed with a logic element, and
- (2) A high-frequency oscillation circuit, which
comprises a crystal oscillator having a basic oscillation
20 frequency in a high frequency area, in a closed circuit
that is formed so as to connect the input and output of a
logic element.

PREFERRED EMBODIMENTS OF THE INVENTION

25 In the following, the present invention is described

in more detail, but the invention is not limited thereto.

Embodiments 1

The high-frequency oscillation circuits, in case a logic element NAND is used, are shown in Figs. 1 and 2, respectively. Fig. 1(a) shows an example of an oscillation circuit when a crystal oscillator X1 for a basic frequency of 50 MHz is used; Fig. 1(b) shows an oscillation waveform of the same circuit as measured by using an oscilloscope. Fig. 2(a) shows an example of an oscillation circuit when an overtone (oscillation frequency of a sub-oscillation) crystal oscillator X2 in the 3rd or 5th order of 100 MHz is used; Fig. 2(b) shows an oscillation waveform of the same circuit as measured by using an oscilloscope.

In Fig. 1(a) and Fig. 2(a), IC1 - IC3 are NANDs as logic elements, X1 is a crystal oscillator having a basic oscillation frequency of 50 MHz, X2 is a crystal oscillator having a basic oscillation frequency of 100 MHz, C1 - C3 are capacitors, and R1 - R2 are resistors.

Each closed circuit is constituted by connecting the output of the logic element IC1 to the input of IC2, and connecting the output of IC2 to the input of IC1. IC3 is a buffer for taking out the output of the oscillation circuit to the outside. In each of closed circuits a crystal oscillator X1 or X2 is disposed. The impedance of

each of the crystal oscillators X1 and X2 becomes the lowest at their natural oscillation frequencies (i.e., basic oscillation frequencies).

Consequently, in each oscillation circuit, each
5 capacitor C and each resistor R are set at such a value as the circuit impedance has the lowest value where the impedance of the crystal oscillators X1 or X2 is the lowest, in view of the operating speed of the logic element IC.

10 The values of the above circuit components (parts) and the names of the logic elements are shown in Fig. 1(a) and Fig. 2(a), respectively. In Fig. 1(a), the type of the logic elements IC1, IC2 and IC3 are 74LS00; C1 is 10pF; C2 is 7pF; C3 is 100pF; R1 is 470 Ω ; and R2 is 330 Ω . In Fig.
15 2(a), the type of the logic elements IC1, IC2 and IC3 are 74HC00; C2 is 1pF; C3 is 100pF; R1 and R2 are 300 Ω .

However, such values of the circuit parts and names of the logic elements are not absolute, and since the impedance of the circuit is low enough in their vicinities,
20 the circuit will oscillate at the natural oscillation frequencies of the crystal oscillators X1 or X2.

As are clear from Fig. 1(b) and Fig. 2(b), in each of the oscillation circuits shown in Figs. 1 and 2, the waveform at the above circuit constants takes a
25 substantially pure sine wave and can be measured

accurately enough by an ordinary frequency counter.

Embodiments 2

Next, oscillation circuits, in case an inverter is
5 used as a logic element, are shown in Figs. 3 and 4,
respectively. Fig. 3 shows an example of using a crystal
oscillator X1 having a basic oscillation frequency of 155
MHz. Fig. 4 shows an example of using an overtone crystal
oscillator X2 in the 3rd or 5th of 100 MHz.

10 Each symbol is the same as in Embodiments 1. The
logic element IC is an inverter and L1 is an inductance.
Also, IC2 is a buffer to take out the output of the
oscillation circuit outside. In each oscillation circuit,
a closed circuit is constituted by connecting the input
15 and output of the inverter IC1. The crystal oscillator
X1 or X2 is disposed in this closed circuit. The
impedance of each of the crystal oscillators X1 and X2
becomes the lowest at their natural oscillation
frequencies. Consequently, each oscillation circuit
20 oscillates at the natural oscillation frequency of the
crystal oscillator X1 or X2.

Fig. 3(a) shows an example of a circuit which excites
the optimum oscillation at the basic oscillation frequency
of the crystal oscillator X1. The basic oscillation
25 frequency of the crystal oscillator X1 in this example is

155 MHz. The values of the capacitor C1 and the resistor R1 which are concrete circuit parts as well as the name of the logic element IC are shown in the drawing.

Fig. 4(a) shows an example of a circuit which
5 oscillates the most favorably at each overtone. C1 and L1 are for selecting a desired order. The drawings show the value of the circuit parts and the name of the logic element in case the circuit is oscillated at the natural oscillation frequency of 100 MHz by using the 5th order
10 (or 3rd order of 33 MHz) of the crystal oscillator X2 having the basic oscillation frequency of 20 MHz.

In Fig. 3(a), the type of the logic elements IC1 and IC2 are 74HCU04AP; C1 is 50pF; R1 is 500k Ω ; and L1 is 0.5 μ H. In Fig. 4(a), the type of the logic elements IC1
15 and IC2 are 74HCU04; C1 is 150pF; R1 is 100 Ω ; and L1 is 0.5 μ H.

These value of the circuit parts and name of logic element are not definite, but it is the same as in case of Embodiments 1 in that, if a value is in the vicinity, the
20 impedance of the circuit is low enough, so the circuit will oscillate at the natural oscillation frequency of the crystal oscillator X1 or X2.

As are clear from Fig. 3(b) and Fig. 4(b), in each of the oscillation circuits, the waveforms at the above
25 circuit constant show a substantially pure sine wave, and

the frequency can be measured accurately enough by an ordinary frequency counter.

Fig. 5 shows the degree of stability of the oscillation frequency in an hour in case of the circuit having the oscillation frequency of 100 MHz using an ordinary crystal oscillator, in the Embodiment shown in Fig. 2(a). Fig. 6 shows the degree of stability of the oscillation frequency in an hour in case of the circuit using a crystal oscillator on which a styrene film is deposited for one minute by a plasma-polymerization method, in which the circuit having an oscillation frequency of 100 MHz is the same one of the embodiment as shown in Fig. 2(a).

It will be understood from Fig. 5 that, by maintaining constant the temperature of each of oscillation circuits mentioned in Embodiments 1, the variation in oscillation frequency of the circuit per hour is of a value within the range of 10 Hz. Further, as shown in Fig. 6, the variation in oscillation frequency per hour of the circuit using the crystal oscillator on which a styrene film is deposited for one minute by plasma polymerization method is also within the range of 10 Hz.

It is also confirmed that each of the circuits in Embodiments 2 shows the same oscillation property of a highly stable high-frequency as in Embodiments 1.

Embodiment 3

A high-frequency oscillation circuit using an inverter as a logic element is shown in Fig. 7. Fig. 7 shows an
5 oscillation circuit using a crystal oscillator whose basic oscillation frequency is between 20 MHz and 155 MHz.

In Fig. 7, IC1 and IC2 are inverters as logic elements; X is a crystal oscillator; C is a capacitor; and R is a resistor. The concrete values of the capacitor C
10 and the resistor R and the name of the logic element IC are shown in the drawing. Further, IC2 is a buffer to take out the output of the oscillation circuit outside.

In this oscillation circuit, a closed circuit is constituted by connecting the input and the output of the
15 inverter IC1. The crystal oscillator X is placed in this closed circuit. The impedance of the crystal oscillator X becomes the lowest at its basic oscillation frequency. Accordingly, the circuit will oscillate at the natural oscillation frequency of the crystal oscillator X. For
20 instance, the oscillation frequency can be 1 to 19 MHz, 20 MHz, 33 MHz, 50 MHz, and 155 MHz in the circuit of Fig. 7.

In Fig. 7, the type of the inverter IC1 and IC2 is 74HCU04AP; R is 500 k Ω ; and C is 1000 pF.

The above values of the circuit elements and the names
25 of the logic elements are not restrictive, but, since the

impedance of the circuit is low enough in the vicinities,
the oscillation circuit oscillates at the basic
oscillation frequency of the crystal oscillator X. It is
desirable to select a logic element CMOS capable of coping
5 with this range of frequency.

Fig 8(a), (b), (c) and (d) show output waveforms
measured by an oscilloscope in case crystal oscillators X
having basic oscillation frequencies of 20 MHz, 33 MHz, 50
MHz, and 155 MHz are respectively used in the circuit of
10 Fig. 7. As is clear from each Figure, the output waveform
by the above circuit constant has a shape between a
rectangular and a sine wave and shows approximately a sine
wave at 155 MHz. The oscillation frequency of the
oscillation circuit showing these output waveforms can be
15 sufficiently measured by an ordinary frequency counter.

Thus, by selectively using one of crystal oscillators
X having various basic oscillation frequencies from 1 MHz
to 2 GHz, they can be oscillated on the same circuit at
the basic oscillation frequency of each crystal oscillator.
20 Conventionally, it has been a common knowledge to design
and constitute an oscillation circuit the most favorable
for each crystal oscillator. The present invention
overturns the common knowledge regarding conventional
oscillation circuits.

25 Figs. 9(a) and 9(b) show changes in the oscillation

frequency with the lapse of time when one of the oscillation circuits of Fig. 7 is used and saturated acetone steam of the same concentration (as measured by extracting 2 ml of head space of the acetone solution and
5 injecting it into a gas adsorption measurement vessel of 1000 ml) is adsorbed on crystal oscillators (of 9 MHz, 50 MHz, 155 MHz) coated with a plasma polymerized styrene film of the same weight (subjected to electric discharge output of 100 W, monomer pressure of 100 Pa, and 1 minute
10 of polymerization time).

In Figs. 9(a) and 9(b), gas adsorption responses are shown, when measured, respectively, by using: (●) a crystal oscillator having a basic oscillation frequency of 9 MHz; (○) a crystal oscillator having a basic
15 oscillation frequency of 50 MHz; and (▼) a crystal oscillator having a basic oscillation frequency of 155 MHz. As the basic oscillation frequencies of the crystal increase, the amount of change in frequency responding to the acetone steam of the same concentration remarkably
20 increases.

In Figs. 9(a) and 9(b), the average values of gas adsorption at respective frequencies show frequency responses of 30 Hz in case of 9 MHz (●), 1200 Hz in case of 50 MHz (○), and 2500 Hz in case of 155 MHz (▼),
25 respectively. Evidently, the higher the basic oscillation

frequency of a crystal oscillator used for gas adsorption is, the greater amount of response by gas adsorption is shown.

In the high frequency oscillation circuit shown in Fig. 7, it is not necessary to change the circuit constant in correspondence to the basic oscillation frequency of the crystal oscillator to be used. With such an oscillation circuit, it is possible to cope with as it is, even if a crystal oscillator as a sensor is changed according to purposes of measurement so as to change a basic frequency, which was heretofore difficult. If such a high-frequency oscillation circuit is used, a precision high-sensitive measuring instrument which is the most favorable for measurement of a super-high sensitive gas sensor or the amount of floating dust can be readily fabricated.

The high-frequency oscillation circuit using the logic elements according to the present invention, though using inexpensive parts and being a simple circuit, continues highly stable oscillation by a crystal oscillator having a high natural oscillation frequency.

As a result, the high-frequency oscillation circuit of the present invention enables to measure precisely a delicate change in natural oscillation frequency of a crystal oscillator as a sensor, and a use of such a high-frequency oscillation circuit enables to readily fabricate

a super-high-sensitive, precision measurement instrument favorable for measurement such as a super-high sensitive weight sensor, a viscosity sensor, and the like.

5 Having described our invention as related to the present embodiments, it is our intention that the invention not be limited by any of the details of the description, unless otherwise specified, but rather be construed broadly within its spirit and scope as set out in the accompanying claims.